

FORM PTO-1449 (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. ASA-936-03		SERIAL NO. 10/663,779	
LIST OF DOCUMENTS CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Y. KAMIGAKI et al		FILING DATE September 17, 2003	
				GROUP			
U.S. PATENT DOCUMENTS							
* EXAMINER INITIAL		DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)
72	AA	4,527,259	07/02/85	Watanabe			
	AB	5,763,308	06/09/98	Choi			
	AC	5,467,308	11/14/95	Chang et al			
	AD	5,408,115	04/18/95	Chang			
	AE	5,923,978	07/1999	Hisamune			
	AF	5,357,134	10/1994	Shimoji			
	AG	5,859,459	01/1999	Ikeda			
	AH	4,185,318	01/1980	Engeler et al			
	AI	6,348,387	02/2002	Yu			
	AJ	6,563,151	05/2003	Shin et al			
72	AK	5,877,523	03/02/99	Liang et al			
FOREIGN PATENT DOCUMENTS							
		DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATIO YES NO
72	AL	0 464664	01/08/92	EP			<input checked="" type="checkbox"/> <input type="checkbox"/>
	AM						<input type="checkbox"/> <input type="checkbox"/>
	AN						<input type="checkbox"/> <input type="checkbox"/>
	AO						<input type="checkbox"/> <input type="checkbox"/>
	AP						<input type="checkbox"/> <input type="checkbox"/>
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
72	AR	International Conference on Solid State Devices and Materials, Tokyo, 1999, pp. 522-523.					
72	AS	IEEE TRANSACTIONS ON COMPONENTS, PACKAGING, AND MANUFACTURING TECHNOLOGY - PART A, Vol. 20, No. 2, June 1997, pp. 182-189.					
72	AT	IEEE ELECTRON DEVICE LETTERS, Vol. 19, No. 7, July 1998, pp. 253-255.					
EXAMINER Kevin Quinto				DATE CONSIDERED 3/20/09			

* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form next communication to applicant.

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U.S. PATENT DOCUMENTS						
* EXAMINER INITIAL	DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE <i>(If Appropriate)</i>
72	AA	5,768,192	6/16/98	Eitan		
72	AB	4,554,643	11/19/85	Kuo		
	AC					
	AD					
	AE					
	AF					
	AG					
	AH					
	AI					
	AJ					
	AK					
FOREIGN PATENT DOCUMENTS						
	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATIO YES NO
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	AM					<input type="checkbox"/> <input type="checkbox"/>
	AN					<input type="checkbox"/> <input type="checkbox"/>
	AO					<input type="checkbox"/> <input type="checkbox"/>
	AP					<input type="checkbox"/> <input type="checkbox"/>
OTHER DOCUMENTS <i>(Including Author, Title, Date, Pertinent Pages, etc.)</i>						
72	AR	IEDM 94, pp. 57-60.				
	AS					
	AT					
EXAMINER Kern D. H. H.				DATE CONSIDERED 3/20/04		
<small>* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form next communication to applicant.</small>						